

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i> <div style="border: 1px solid black; border-radius: 50%; width: 100px; height: 100px; margin: 10px auto; display: flex; align-items: center; justify-content: center;"> <div style="writing-mode: vertical-rl; transform: rotate(180deg); font-weight: bold;">COPY</div> <div style="text-align: center;"> JUN 25 2004 PATENT & TRADEMARK OFFICE </div> </div>				ATTY DOCKET NO. 04558/085001		APPLICATION NO. 10/810,505		
				APPLICANT(S) Eri Kojima, et al.				
				FILING DATE 03/26/2004		GROUP ART UNIT 1745		
				U.S. PATENT DOCUMENTS				
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
/RA/	A1	US 2002/0177044 A1	11/28/2002	Yagi, et al.	429	231.95	04/11/2002	
U.S. PATENT APPLICATION PUBLICATIONS								
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/RA/	B1	2001-256968	09/21/2001	Japan	H01M	4/02		✓
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
/RA/	C1	Patent Abstracts of Japan, publication no.: 2001-256968, publication date 09/21/2001, 1 page						
/RA/	C2	Robert A. Huggins, "Lithium alloy negative electrodes formed from convertible oxides" Solid State Ionics, 113-115 (1998), p. 57-67						
EXAMINER /Raymond Alejandro/				DATE CONSIDERED 04/18/2007				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				ATTY DOCKET NO. 04558/085001		APPLICATION NO. 10/810,505	
				Eri Kojima, et al.			
				FILING 03/26/2004		GROUP ART 1745	

OFFICE
 JUN 25 2004
 PATENT & TRADEMARK OFFICE

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>			
/RA/		C3	Noriyuki Tamura et al., "Study on the anode behavior of Sn and Sn-Cu alloy thin-film electrodes", Journal of Power Sources 107 (2002) p. 48-55
/RA/		C4	D. Larcher et al., "In Situ X-Ray Study of the Electrochemical Reaction of Li and n'-Cu6Sn5" Journal of The Electrochemical Society, 147 (2000) p. 1658-1662 5 pages

EXAMINER /Raymond Alejandro/	DATE CONSIDERED 04/18/2007
--	--------------------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

APR 10 2007

PTO/SB/08A/B (09-06)

Approved for use through 03/31/2007. OMB 0661-0031

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Application Number	10/810,505-Conf. #8177
				Filing Date	March 26, 2004
				First Named Inventor	Eri KOJIMA
				Art Unit	1745
				Examiner Name	R. Alejandro
Sheet	1	of	1	Attorney Docket Number	5271-0113PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/RA/	AA*	US-2003/0180619-A1	09-25-2003	Tamura et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
/RA/	BA	JP-2002-373647-A	12-26-2002			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO: Those application(s) which are marked with an asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 601.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST 3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Raymond Alejandro/	Date Considered	04/18/2007
--------------------	---------------------	-----------------	------------

Birch, Stewart, Kolasch & Birch, LLP

JWB/ETP/las